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| PPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO |
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| 10/620,015 | 07/14/2003 | Eun-Sung Seo | 9898-291 | 9260 |
| 7590 06/03/2004 | | | EXAMINER | |
| MARGER JOHNSON & McCOLLOM, P.C. | | | VU, QUANG D | |
| 1030 S. W. Morrison Street Portland, OR 97205 | | | ART UNIT | PAPER NUMBER |
| 2010.00.00 | | • | 2811 | |
| | | | DATE MAILED: 06/03/2004 | |

Please find below and/or attached an Office communication concerning this application or proceeding.

| <u> </u> | Application No. | Applicant(s) | | | | | |
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| | 10/620,015 | SEO ET AL. | A | | | | |
| Office Action Summary | Examiner | Art Unit | | | | | |
| | Quang D Vu | 2811 | | | | | |
| The MAILING DATE of this communication app Period for Reply | ears on the cover sheet with the c | orrespondence add | ress | | | | |
| A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b). | 36(a). In no event, however, may a reply be ting within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE | nely filed s will be considered timely. the mailing date of this con CO (35 U.S.C. § 133). | nmunication. | | | | |
| Status | | | | | | | |
| 1) Responsive to communication(s) filed on | | | | | | | |
| 2a) This action is FINAL . 2b) ☑ This | action is non-final. | | | | | | |
| 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is | | | | | | | |
| closed in accordance with the practice under E | x parte Quayle, 1935 C.D. 11, 4 | 53 O.G. 213. | * | | | | |
| | | | | | | | |
| Disposition of Claims | | Company of the cold of the said | and the second s | | | | |
| 4) Claim(s) <u>1-20</u> is/are pending in the application. | | | · . | | | | |
| 4a) Of the above claim(s) is/are withdray | vn from consideration. | A Dr. Gills | | | | | |
| 5) Claim(s) is/are allowed. | n mentan ing kanasala | and the second second | • | | | | |
| 6)⊠" Claim(s) <u>1-20</u> is/are rejected. | · | | | | | | |
| 7) Claim(s) is/are objected to. | to the second of | and the second of the second o | The Market | | | | |
| 8) Claim(s) are subject to restriction and/o | r election requirement. | | | | | | |
| Application Papers | | | | | | | |
| 9) The specification is objected to by the Examine | ı r | | | | | | |
| 10) The drawing(s) filed on is/are: a) accompany | | Examiner | | | | | |
| Applicant may not request that any objection to the | . • | | | | | | |
| Replacement drawing sheet(s) including the correct | : | | R 1.121(d). | | | | |
| 11) The oath or declaration is objected to by the Ex | | | 4 . | | | | |
| or internal constitution of the control of the cont | | | • | | | | |
| Priority under 35 U.S.C. § 119 | | | | | | | |
| 12) Acknowledgment is made of a claim for foreign | priority under 35 U.S.C. § 119(a |)-(d) or (f). | | | | | |
| a)⊠ All b)□ Some * c)□ None of: | | | | | | | |
| 1. Certified copies of the priority document | | | | | | | |
| 2. Certified copies of the priority document | | | | | | | |
| 3. Copies of the certified copies of the prior | | ed in this National S | Stage | | | | |
| application from the International Bureau | • | | ÷ | | | | |
| * See the attached detailed Office action for a list | of the certified copies not receive | ed. | | | | | |
| | <u> </u> | | | | | | |
| | | | | | | | |
| Attachment(s) | 4) Interview Summar | v (PT∩_413) | | | | | |
| Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) | Paper No(s)/Mail D | Date | A to the state of | | | | |
| 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) | 5) Notice of Informal | Patent Application (PTO | -152) | | | | |
| Paper No(s)/Mail Date | 6) | | | | | | |

Art Unit: 2811

DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over US Patent No. 5,905,295 to Prall et al. in view of US Patent No. 6,355,968 to Lehmann et al.

Regarding claim 1, Prall et al. (figures 1A-B) teach a fuse bank of a semiconductor memory device comprising:

a first laser fuse (101) which includes a first laser fusing region which is disposed in a first direction; and

- a second laser fuse (102) which includes a second laser fusing region which is disposed in the first direction,

wherein the first laser fuse (101) and the second laser fuse (102) are disposed adjacently with a space of a predetermined distance there between, the first laser fusing region (101) and the second laser fusing region (102) form a laser fusing region of the fuse bank, and the first laser fuse and the second laser fuse are disposed on a plane.

Prall et al. differ from the claimed invention by not showing a first connecting line region which is disposed to be bent in a second direction; a second connecting line region which is disposed to be bent in a third direction; a third connecting line region which is disposed to be

Art Unit: 2811

bent in the second direction; and a fourth connecting line region which is disposed to be bent in the third direction. However, Lehmann et al. teach conductive lines pass on the same level of the fuses (column 2, lines 15-19). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate the teaching of Lehmann et al. into the device taught by Prall et al. because it provides interconnection in the fuse bank. The combined device shows a first connecting line region which is disposed to be bent in a second direction; a second connecting line region which is disposed to be bent in a third direction; a third connecting line region which is disposed to be bent in the second direction; and a fourth connecting line region which is disposed to be bent in the third direction.

Regarding claim 2, the combined device shows the laser fusing region has a parallelogram shape.

Regarding claim 3, the combined device shows the first direction is perpendicular to the second direction and the third direction.

Regarding claim 4, the combined device shows the second direction is opposite to the third direction.

Regarding claim 5, Prall et al. (figures 1A-B) teach a fuse bank of a semiconductor memory device comprising:

a first laser fuse group which has multiple laser fuses (101, 102, 103) arranged in a first direction with a space of a predetermined distance there between; and

a second laser fuse group that has multiple laser fuses (101', 102', 103') arranged in the first direction with a space of a predetermined distance there between,

Art Unit: 2811

wherein the first laser fuse group (101, 102, 103) and the second laser fuse group (101', 102', 103') each include a laser fusing region which is disposed in the first direction, and the first laser fuse and the second laser fuse are adjacently disposed on a plane.

Prail et al. differ from the claimed invention by not showing a first connecting line region which is disposed to be bent in a second direction, and a second connecting line region which is disposed to be bent in a third direction. However, Lehmann et al. teach conductive lines pass on the same level of the fuses (column 2, lines 15-19). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate the teaching of Lehmann et al. into the device taught by Prall et al. because it provides interconnection in the fuse bank. The combined device shows a first connecting line region which is disposed to be bent in a second direction, and a second connecting line region which is disposed to be bent in a third direction.

Regarding claim 6, the combined device shows the laser fusing region has a parallelogram shape.

Regarding claim 7, the combined device shows the first direction is perpendicular to the second direction and the third direction.

Regarding claim 8, the combined device shows the second direction is opposite to the third direction.

Regarding claim 9, the combined device shows the first laser fuse group and the second laser fuse group are disposed repeatedly.

Regarding claim 10, Prall et al. (figures 1A-B) teach a fuse bank of a semiconductor memory device comprising:

Art Unit: 2811

a first laser fuse group which has multiple laser fuses (101, 102, 103) arranged in a first direction with a space of a predetermined distance there between; and

a second laser fuse group that has multiple laser fuses (101', 102', 103') arranged in the first direction with a space of a predetermined distance there between,

wherein the first laser fuse group (101, 102, 103) and the second laser fuse group (101', 102', 103') each include a laser fusing region which is disposed in the first direction, the first laser fuse group (101, 102, 103) and the second laser fuse group (101', 102', 103') are disposed adjacently, the first laser fuse group and the second laser fuse group are disposed to be symmetrical about the direction perpendicular to the first direction, and the first laser fuse group (101, 102, 103) and the second laser fuse group (101', 102', 103') are disposed on a plane.

Prall et al. differ from the claimed invention by not showing a first connecting line region which is disposed to be bent in a second direction, and a second connecting line region which is disposed to be bent in a third direction. However, Lehmann et al. teach conductive lines pass on the same level of the fuses (column 2, lines 15-19). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate the teaching of Lehmann et al. into the device taught by Prall et al. because it provides interconnection in the fuse bank. The combined device shows a first connecting line region which is disposed to be bent in a second direction, and a second connecting line region which is disposed to be bent in a third direction.

Regarding claim 11, the combined device shows the laser fusing region has a parallelogram shape.

Art Unit: 2811

Regarding claim 12, the combined device shows the first direction is perpendicular to the second direction and the third direction.

Regarding claim 13, the combined device shows the second direction is opposite to the third direction.

Regarding claim 14, the combined device shows the first laser fuse group and the second laser fuse group are disposed repeatedly.

Regarding claim 15, Prall et al. (figures 1A-B) teach a fuse bank, comprising:

a fuse region formed from a first fuse region (101) and a second fuse region (102) arranged parallel to each other, each with a first end and a second end.

Prall et al. differ from the claimed invention by not showing connecting lines connected to each of the first and second fuse regions, such that each of the first and second fuse regions has a connecting line on each end, wherein connecting lines on the first end are perpendicular to the first and second fuse regions in a first direction and connecting lines on the second end are perpendicular to the first and second fuse regions in a second direction. However, Lehmann et al. teach conductive lines pass on the same level of the fuses (column 2, lines 15-19). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate the teaching of Lehmann et al. into the device taught by Prall et al. because it provides interconnection in the fuse bank. The combined device shows connecting lines connected to each of the first and second fuse regions, such that each of the first and second fuse regions has a connecting line on each end, wherein connecting lines on the first end are perpendicular to the first and second fuse regions in a first direction and connecting lines on the second end are perpendicular to the first and second fuse regions in a second direction.

Art Unit: 2811

Regarding claim 16, the combined device shows the first and second fuse regions being offset from each other a predetermined distance.

Regarding claim 17, the combined device shows connecting lines at each end of the fuse region being offset from each other a predetermined distance.

Regarding claim 18, Prall et al. (figures 1A-B) teach a fuse bank, comprising:

at least two fuses (a first group [101, 102, 103]; a second group [101', 102', 103']), each fuse comprising:

a plurality of fuse regions (101, 102, 103, 101', 102', 103'), each having a first end and a second end, arranged parallel to each other and offset from each other a predetermined distance.

Prall et al. differ from the claimed invention by not showing a plurality of connecting lines, one disposed at the first and second ends of each of the plurality of fuse regions, wherein the plurality of connecting lines are perpendicular to the plurality of fuse regions. However, Lehmann et al. teach conductive lines pass on the same level of the fuses (column 2, lines 15-19). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to incorporate the teaching of Lehmann et al. into the device taught by Prall et al. because it provides interconnection in the fuse bank. The combined device shows a plurality of connecting lines, one disposed at the first and second ends of each of the plurality of fuse regions, wherein the plurality of connecting lines are perpendicular to the plurality of fuse regions.

Regarding claim 19, the combined device shows the connecting lines disposed at the first end of a first fuse and a second fuse arranged in a first direction and the connecting lines disposed at the second end of the first fuse and the second fuse arranged in a second direction.

Art Unit: 2811

Regarding claim 20, the combined device shows the connecting lines at the first end of a first fuse and the second end of a second fuse arranged in a first direction and the connecting lines at the second end of the first fuse and the first end of the second fuse arranged in a second direction.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Quang D Vu whose telephone number is 571-272-1667. The examiner can normally be reached on Monday-Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lee can be reached on 571-272-1732. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

qv May 27, 2004

Sara Crane
Primary Examiner